Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/603,667	OHKAWA ET AL.
Examiner	Art Unit
Son M. Tang	2612

	SEARCHED					
Class	Subclass	Date	Examiner			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
340	572.7	6/21/2006	TANG		
1	572.1				
	572.4				
340/572.6,572.8					

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
340/571-572.8 Text only	6/21/2006	TANG			
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